

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10577174	INOUE, MASASHI
	<b>Examiner</b>	<b>Art Unit</b>
	Muktesh G Gupta	2144

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
709	226	03/06/2008	MG
718	105	03/06/2008	MG
707	2	09/10/2008	MG

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor name searched in PALM and eDAN	03/06/2008	MG
Class searched in combination with Text search	03/06/2008	MG
(Transaction or Resource or Eliminate or Monitor\$3 or Detect or select or predesignate or remove or sequence or response or access\$3 or relat\$3 or averag\$3 or identif\$4 or High\$3 or Peak\$3 or Range or period)	03/06/2008	MG
(Load Balanc\$3) same (server or program or application or database or process\$3 or contol\$4 or bottleneck)	03/06/2008	MG
Discussed Application with SPE William Vaughn	09/08/2008	MG
Inventor name assignee searched for Double Patenting	09/10/2008	MG
Interference search done in EAST	09/10/2008	MG
Updated Search in EAST	09/10/2008	MG
101, 102, 103 compliance checked	09/10/2008	MG
Updated search history attached	09/10/2008	MG
EIC Fast and Focus search done	09/10/2008	MG

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	202	09/10/2008	MG
709	228	09/10/2008	MG
718	106	09/10/2008	MG

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